

**Search Notes**

Application/Control No.

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Examiner

Hanh V. Tran

Applicant(s)/Patent under  
Reexamination

ZAKARIA ET AL.

Art Unit

3637

**SEARCHED**

Class	Subclass	Date	Examiner
108	51.11 20	10/30/2006	HVT
	147 55.1		
206	386 600		
312	306	10/30/2006	HVT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East text search using various key words	10/30/2006	HVT